

# Métamodèles pour l'estimation de bornes de défaillance par des inégalités de concentration de mesures optimales

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# Uncertainty quantification vs. robust certification

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- "Les industriels se plaignent de ne pas voir assez de propagation d'incertitudes dans le PSS" (AM 21/07/2015);
- FP7 UMRIDA (2013-2016, PI C. Hirsch):
  - ① "Address major research challenges in both UQ and RDM to develop new methods able to **handle large numbers of simultaneous uncertainties** [...];"
  - ② "Apply the UQ and RDM methods to representative industrial configurations. [...] A new generation of database, formed by industrial challenges, provided by the industrial partners, **with prescribed uncertainties**, is established."
- Optimization in terms of a **mean**, **nominal**, or **extreme** performance ("hero calculation").
- But the **probability** of deviating from that nominal performance may be non negligible!

# Outline

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1 Certification and UQ

2 Optimal Uncertainty Quantification

3 Examples

4 Adaptive reconstruction

# The UQ problem in a robust certification context

- **Uncertainty Quantification** (UQ) usually refers to the quantitative characterization and reduction of uncertainties in physical processes (computational or real-world problems).
- **Certification** is defined here as the process of guaranteeing that the probability  $\mathbb{P}$  of exceeding a given threshold  $a$  is below an acceptable tolerance  $\epsilon$ :

$$\mathbb{P}_{\mathbf{X} \sim \mu^\dagger} [F(\mathbf{X}) \geq a] = \mathbb{E}_{\mathbf{X} \sim \mu^\dagger} \{ \mathbb{1}(F(\mathbf{X}) \geq a) \} \leq \epsilon,$$

where  $F$  is the performance function and  $\mathbf{X}$  are the variable input parameters following the distribution  $\mu^\dagger$ ;

- $\mathbb{P}_{\mathbf{X} \sim \mu^\dagger} [F(\mathbf{X}) \geq a]$  will be called "**probability of failure**."
- **Robust certification**: finding bounds on the "probability of failure."

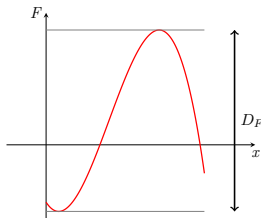
# Concentration-of-measure (CoM)

- A real function  $\mathbf{X} \mapsto F(\mathbf{X})$  oscillating about its mean  $\mathbb{E}\{F(\mathbf{X})\}$  without *a priori* knowledge of the PDFs of the random inputs  $\mathbf{X} = (X_1, \dots, X_d)^T : \Omega \rightarrow \mathcal{X} = \mathcal{X}_1 \times \dots \times \mathcal{X}_d$ .
- Assuming that the latter are **independent**, the following **McDiarmid's inequality** holds for all  $a > 0$ :

$$\mathbb{P}[|F(\mathbf{X}) - \mathbb{E}\{F(\mathbf{X})\}| \geq a] \leq \exp\left(-2 \frac{a^2}{D_F^2}\right),$$

where  $D_F = (\sum_{j=1}^d \text{Osc}_j(F)^2)^{\frac{1}{2}}$  is the **verification diameter** of the function  $F$ , and for  $1 \leq j \leq d$ :

$$\text{Osc}_j(F) = \sup_{\mathbf{x} \in \mathcal{X}} \sup_{x'_j \in \mathcal{X}_j} \left| F(x_1, \dots, x_{j-1}, x_j, x_{j+1}, \dots, x_d) - F(x_1, \dots, x_{j-1}, x'_j, x_{j+1}, \dots, x_d) \right|.$$



S. Boucheron, G. Lugosi, P. Massart. *Concentration Inequalities*. Oxford University Press, Oxford (2013)  
 M. Ledoux. *The Concentration-of-Measure Phenomenon*. American Mathematical Society, Providence RI (2001)  
<https://terrytao.wordpress.com/2010/01/03/254a-notes-1-concentration-of-measure/>

# Examples

- Let  $F(\mathbf{X}) = \frac{1}{d} \sum_{j=1}^d X_j$  and  $\mathcal{X}_j = [a_j, b_j]$ . Then  $\text{Osc}_j(F) = \frac{1}{d}(b_j - a_j)$ , and the following **Hoeffding's inequality** holds for all  $a > 0$ :

$$\mathbb{P}[|F(\mathbf{X}) - \mathbb{E}\{F(\mathbf{X})\}| \geq a] \leq \exp\left(\frac{-2a^2 d^2}{\sum_{j=1}^d (b_j - a_j)^2}\right).$$

Thus if  $b_j - a_j = \Delta$  for all inputs, one has:

$$\mathbb{P}[|F(\mathbf{X}) - \mathbb{E}\{F(\mathbf{X})\}| \geq a] \leq \exp\left(-2d \frac{a^2}{\Delta^2}\right);$$

the higher  $d$  is, the less  $F(\mathbf{X})$  deviates from its mean  $\mathbb{E}\{F(\mathbf{X})\}$ .

- CoM phenomenon**: functions over high-dimensional spaces with small local oscillations in each variable are almost constant (Paul Levy 1951).

# Examples

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- **Markov's inequality** for a non-negative r.v.  $X$  s.t.  $\mathbb{E}\{X\} < +\infty$ :

$$\mathbb{P}[X \geq a] \leq \frac{\mathbb{E}\{X\}}{a}.$$

- **Chebyshev's inequality** for  $x \mapsto F(x)$  monotonous, non-decreasing:

$$\mathbb{P}[X \geq a] \leq \frac{\mathbb{E}\{F(X)\}}{F(a)}.$$

# Application to certification

- **Performance measure:** assume  $\mathbf{X} \mapsto F(\mathbf{X})$  is a performance measure of the system under consideration, such as a **limit stress** in structural design for which  $\mathbf{X}$  are  $d$  varying geometrical parameters, physical parameters, operational conditions, numerical error sources, *etc.*
- Performance is formulated as the constraint  $\{F(\mathbf{X}) \leq a\}$ , where  $a$ : target threshold for the operation of the system.
- Then McDiarmid's inequality yields:

$$\mathbb{P}[F(\mathbf{X}) \geq a] \leq \exp\left(-2 \frac{(a - \mathbb{E}\{F(\mathbf{X})\})_+^2}{D_F^2}\right) \leq \epsilon,$$

where  $x_+ := \max(0, x)$  (this thresholding stems from the fact that if the mean performance is  $\mathbb{E}\{F(\mathbf{X})\} \geq a$  then very little chance remains to certify the system).

- **Quantification of margins and uncertainties:**

- $(a - \mathbb{E}\{F(\mathbf{X})\})_+$  is the **margin**  $M$ ;
- $D_F$  is the **uncertainty measure**  $U$ ;
- $CF = \frac{M}{U}$  is then the **confidence factor**.

Therefore  $\mathbb{P}[F(\mathbf{X}) \geq a] \leq \epsilon$  provided that the confidence factor is  $CF > \sqrt{\ln \frac{1}{\epsilon}}$ .

L. J. Lucas, H. Owhadi, M. Ortiz. *Comput. Methods Appl. Mech. Engrg.* **197**(51-52), 4591-4609 (2008)



# Application to certification

- **Performance measures:** the analysis extends to multiple performance measures, formulated as e.g. the constraints  $\{F_1(\mathbf{X}) \leq a_1\} \cap \{F_2(\mathbf{X}) \geq a_2\}$ .
- Then McDiarmid's inequality yields:

$$\mathbb{P}[\{F_1(\mathbf{X}) \geq a_1\} \cap \{F_2(\mathbf{X}) \leq a_2\}] \\ \leq \exp\left(-2 \frac{(a_1 - \mathbb{E}\{F_1(\mathbf{X})\})_+^2}{D_1^2}\right) + \exp\left(-2 \frac{(\mathbb{E}\{F_2(\mathbf{X})\} - a_2)_+^2}{D_2^2}\right).$$

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# Model-based certification

- The goal is to achieve rigorous certification with a maximum use of modeling and simulation and a minimum use of testing.
- Assume a (low-fidelity) **model**  $\mathbf{X} \mapsto G(\mathbf{X})$  is used to assess the (high-fidelity) **system response function**, or performance  $\mathbf{X} \mapsto F(\mathbf{X})$ .
- Applying once again McDiarmid's inequality to  $F$  yields:

$$\begin{aligned}\mathbb{P}[F(\mathbf{X}) \geq a] &\leq \exp\left(-2 \frac{(a - \mathbb{E}\{F(\mathbf{X})\})_+^2}{D_F^2}\right) \\ &\leq \exp\left(-2 \frac{(a - \mathbb{E}\{F(\mathbf{X})\})_+^2}{(D_G + D_{F-G})^2}\right),\end{aligned}$$

owing to the triangular inequality  $D_F \leq D_G + D_{F-G}$ .

# Model-based certification

- The **mean performance**  $\mathbb{E}\{F(\mathbf{X})\}$  is assessed from legacy data, testing, or MDO for example;<sup>a</sup>
- $D_G$  is the **predicted model diameter**, *i.e.* a measure of the system uncertainty obtained by exerting the model without any testing;
- $D_{F-G}$  is the **model-error diameter**, *i.e.* a quantitative measure of the model fidelity, or the discrepancy between model predictions and legacy data/experimental observations.
- One expects  $D_{F-G} \ll D_F$  and  $D_{F-G} \ll D_G$  for high-fidelity models, whence the number of tests required to compute  $D_{F-G}$  is minimized because (iterative) global optimization algorithms may converge rapidly.

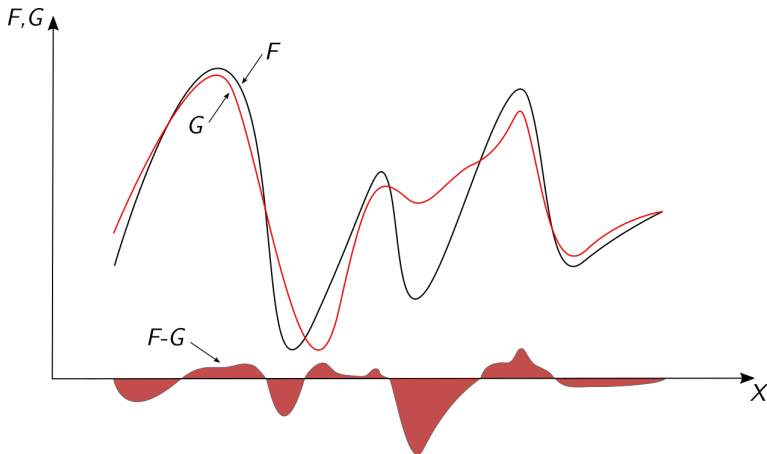
<sup>a</sup>Empirical mean  $\underline{E} = \frac{1}{m} \sum_{j=1}^m F(\mathbf{X}_j)$  such that  $D_{\underline{E}}^2 = \frac{1}{m} D_F^2$  and:

$$\mathbb{P}[|\underline{E} - \mathbb{E}\{F(\mathbf{X})\}| \geq \alpha] \leq \exp\left(-2 \frac{\alpha^2}{D_{\underline{E}}^2}\right) = \epsilon'.$$

Then the margin is reduced by  $\alpha$ :  $M' = (a - \alpha - \underline{E})_+$  where  $\alpha = U \sqrt{\frac{1}{m} \ln \sqrt{\frac{1}{\epsilon'}}}$ , but the uncertainty measure  $U = D_F$  is unchanged; with probability  $1 - \epsilon'$ :

$$\mathbb{P}[F(\mathbf{X}) \geq a] \leq \exp\left(-2 \frac{M'^2}{U^2}\right).$$

# Model-based certification



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# Optimal Uncertainty Quantification

- One wants to certify  $\mathbb{P}_{\mathbf{X} \sim \mu^\dagger} [F(\mathbf{X}) \geq a] \leq \epsilon$  **BUT** so far:

- 1  $F$  and  $\mu^\dagger$  are not known exactly!!!
- 2 One only knows  $(f, \mu^\dagger) \in \mathcal{A}$  where:

$$\mathcal{A} \subset \left\{ (f, \mu) \left| \begin{array}{l} f: \mathcal{X} \rightarrow \mathbb{R} \\ \mu \in \mathcal{P}(\mathcal{X}) \end{array} \right. \right\}.$$

*"When in doubt, assume the worst!"*

- Alternatively one wants to compute optimal bounds:

$$\mathcal{U}[\mathcal{A}] = \sup_{(f, \mu) \in \mathcal{A}} \mu[f(\mathbf{X}) \geq a],$$

$$\mathcal{L}[\mathcal{A}] = \inf_{(f, \mu) \in \mathcal{A}} \mu[f(\mathbf{X}) \geq a],$$

such that  $\mathcal{L}[\mathcal{A}] \leq \mathbb{P}_{\mathbf{X} \sim \mu^\dagger} [F(\mathbf{X}) \geq a] \leq \mathcal{U}[\mathcal{A}]$  and therefore:

- If  $\mathcal{U}[\mathcal{A}] \leq \epsilon$ : the system is safe even in worst case;
- If  $\mathcal{L}[\mathcal{A}] > \epsilon$ : the system is unsafe even in best case;
- If  $\mathcal{L}[\mathcal{A}] \leq \epsilon < \mathcal{U}[\mathcal{A}]$ : one cannot decide.

# Optimal Uncertainty Quantification

- **Reduction theorem:** let

$$\mathcal{A} = \left\{ (f, \mu) \left| \begin{array}{l} f : \mathcal{X}_1 \times \cdots \times \mathcal{X}_d \rightarrow \mathbb{R} \\ \mu = \mu_1 \otimes \cdots \otimes \mu_d \\ C_j(f, \mu) \leq 0, \quad 1 \leq j \leq n_0 \\ C_{j_k}(f, \mu_{j_k}) \leq 0, \quad 1 \leq j_k \leq n_k \end{array} \right. \right\};$$

then  $\mathcal{U}[\mathcal{A}] = \mathcal{U}[\mathcal{A}_\Delta]$  where:

$$\mathcal{A}_\Delta = \left\{ (f, \mu) \in \mathcal{A} \left| \begin{array}{l} \mu_k = \sum_{i=0}^{n_0+n_k} \alpha_i \delta_{x_i} \\ \alpha_i \geq 0, \sum \alpha_i = 1 \end{array} \right. \right\}.$$

- The solution is constructible: open-source `mystic` optimization framework in Python, <https://pypi.org/project/mystic/>, where  $\mathcal{U}[\mathcal{A}_\Delta]$  is computed using e.g. Storn-Price's Differential Evolution algorithm.
- This constrained optimization problem can be transformed to an unconstrained problem through **canonical moments**, as shown by J. Stenger in his PhD thesis (2020).

H. Owhadi et al. *SIAM Rev.* **55**(2), 271-345 (2013)

R. Storn, K. Price. *J. Global Optim.* **11**(4), 341-359 (1997)

J. Stenger, F. Gamboa, M. Keller, B. Iooss. *Int. J. Uncertain. Quantif.* **10**(1), 35-53 (2020)

T. J. Sullivan. *Introduction to Uncertainty Quantification*. Springer, Cham (2015)

# Optimal Uncertainty Quantification

- **Example** (McDiarmid set): let

$$\mathcal{A}_{\text{McD}} = \left\{ (f, \mu) \left| \begin{array}{l} f: \mathcal{X}_1 \times \cdots \times \mathcal{X}_d \rightarrow \mathbb{R} \\ \mu = \mu_1 \otimes \cdots \otimes \mu_d \\ \mathbb{E}_\mu \{f(\mathbf{X})\} \leq 0 \\ \text{Osc}_j(f) \leq D_j, \ 1 \leq j \leq d \end{array} \right. \right\};$$

then  $a \mapsto \mathcal{U}[\mathcal{A}_{\text{McD}}](a) = \sup_{(f, \mu) \in \mathcal{A}} \mu[f(\mathbf{X}) \geq a]$  is given for  $d = 2$  by:

$$\mathcal{U}[\mathcal{A}_{\text{McD}}](a) = \begin{cases} 0 & \text{if } D_1 + D_2 \leq a, \\ \frac{(D_1 + D_2 - a)^2}{4D_1D_2} & \text{if } |D_1 - D_2| \leq a \leq D_1 + D_2, \\ 1 - \frac{a}{\max(D_1, D_2)} & \text{if } 0 \leq a \leq |D_1 - D_2|. \end{cases}$$

The solution is explicit for  $d = 3$  as well.

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# Example #1: Deflection of a cantilever beam

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- **Performance function:**  $\mathbf{X} \mapsto F(\mathbf{X})$  is the maximum deflection of the beam (in mm) with  $\mathbf{X} = (E, R)$ , where  $E$  is its **Young's modulus** and  $R$  its **radius**.
- One wants to certify that the probability that  $F(\mathbf{X})$  exceeds the threshold  $a$  remains below the tolerance  $\epsilon$ , *i.e.*  $\mathbb{P}[F(\mathbf{X}) \geq a] \leq \epsilon$ .
- **Scenario 0:** The performance function  $\mathbf{X} \mapsto F(\mathbf{X})$  and the probability measure  $\mu^\dagger$  are exactly known;

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- **Scenario 1:** Let  $\mathcal{A}_{\text{McD}}$  be McDiarmid's admissible set

$$\mathcal{A}_{\text{McD}} = \left\{ (f, \mu) \left| \begin{array}{l} f : \mathcal{X}_1 \times \mathcal{X}_2 \rightarrow \mathbb{R} \\ \mu = \mu_1 \otimes \mu_2 \\ \mathbb{E}_{\mathbf{X} \sim \mu} \{f(\mathbf{X})\} = \mathbf{U} \\ \text{Osc}_j(f) \leq D_j, \ 1 \leq j \leq 2 \end{array} \right. \right\};$$

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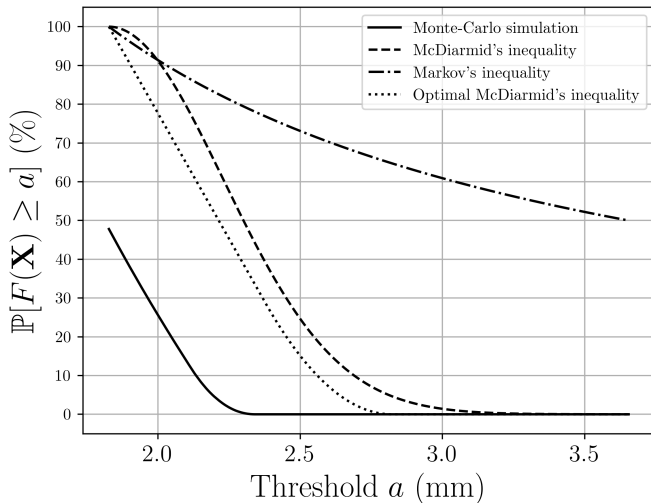
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- **Scenario 2:** Let  $\mathcal{A}_F$  be the following admissible set

$$\mathcal{A}_F = \left\{ (F, \mu) \left| \begin{array}{l} F : \mathcal{X}_1 \times \mathcal{X}_2 \rightarrow \mathbb{R} \text{ is known} \\ \mu = \mu_1 \otimes \mu_2 \\ \mathbb{E}_{\mathbf{X} \sim \mu} \{ F(\mathbf{X}) \} = U \end{array} \right. \right\},$$

where:

$$\begin{array}{lll} E : & \mathcal{X}_1 = [\underline{E} \pm 5\%] \text{ GPa} & \underline{E} = 75 \text{ GPa} \quad D_1 = 0.223 \text{ mm}, \\ R : & \mathcal{X}_2 = [\underline{R} \pm 5\%] \text{ mm} & \underline{R} = 12.5 \text{ mm} \quad D_2 = 0.722 \text{ mm}. \end{array}$$

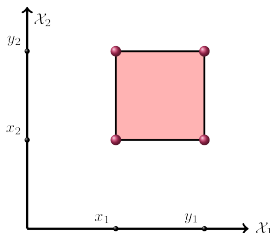
# Example #1 – Scenario 1



# Example #1 – Scenario 2

- We have from the [reduction theorem](#)  $\mathcal{U}[\mathcal{A}_F] = \mathcal{U}[\mathcal{A}_\Delta]$  where:

$$\mathcal{A}_\Delta = \left\{ (F, \mu) \in \mathcal{A}_F \left| \begin{array}{l} \mu_1 = \alpha_1 \delta_{x_1} + (1 - \alpha_1) \delta_{y_1} \\ \mu_2 = \alpha_2 \delta_{x_2} + (1 - \alpha_2) \delta_{y_2} \\ \alpha_1, \alpha_2 \geq 0 \\ x_1, y_1 \in \mathcal{X}_1, x_2, y_2 \in \mathcal{X}_2 \end{array} \right. \right\}.$$



The marginal measures  $\mu_1$  and  $\mu_2$  are supported on [at most 2](#) Dirac points. The support of  $\mu$  consists in at most 4 Dirac support points.

- $\mathcal{U}[\mathcal{A}_\Delta]$  is found using Storn-Price's Differential Evolution algorithm in the `mystic` framework.

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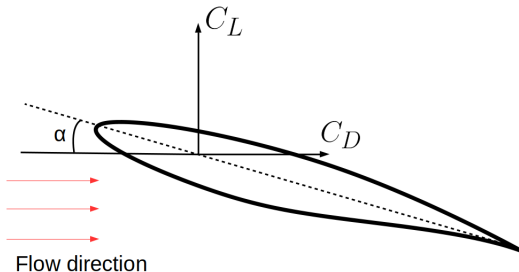
# Example #1 – Summary

Threshold		$a = 2.2 \text{ (mm)}$
Admissible scenario		$\sup_{(f,\mu) \in \mathcal{A}} \mathbb{P}_{\mathbf{X} \sim \mu}[f(\mathbf{X}) \geq a]$
Scenario 1	McDiarmid's inequality	$\leq 65.1\%$
	$\mathcal{U}[\mathcal{A}_{\text{MCD}}]$	$= 51.7\%$
Scenario 2	$\mathcal{U}[\mathcal{A}_F]$	$= 48.7\%$
Scenario 0	$\mathbb{P}[F(\mathbf{X}) \geq a]$ (MC over $10^6$ samples)	$= 4.4\%$

Upper bounds of the probability of failure with threshold  $a = 2.2 \text{ mm}$  for different scenarios.

## Example #2: Lift-to-drag ratio for RAE2822

- **Performance measure:**  $\mathbf{X} \mapsto F(\mathbf{X})$  is the lift-to-drag ratio  $C_L/C_D$  of a RAE2822 wing profile with  $\mathbf{X} = (M, \alpha, t)$ , where  $M$  is the **Mach number**,  $\alpha$  is the **angle of attack**, and  $t$  is some **geometrical imperfection**.
- One wants to certify that the probability that  $F(\mathbf{X})$  is lower than a given threshold  $a$  remains below the tolerance  $\epsilon$ , i.e.  $\mathbb{P}[F(\mathbf{X}) \leq a] \leq \epsilon$ .
- Computations by ISES, a 2D aerodynamic solver developed by M. Drela and M. B. Giles at MIT.





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- **Scenario 1:** Let  $\mathcal{A}_{\text{McD}}$  be McDiarmid's admissible set

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## Example #2: Lift-to-drag ratio for RAE2822

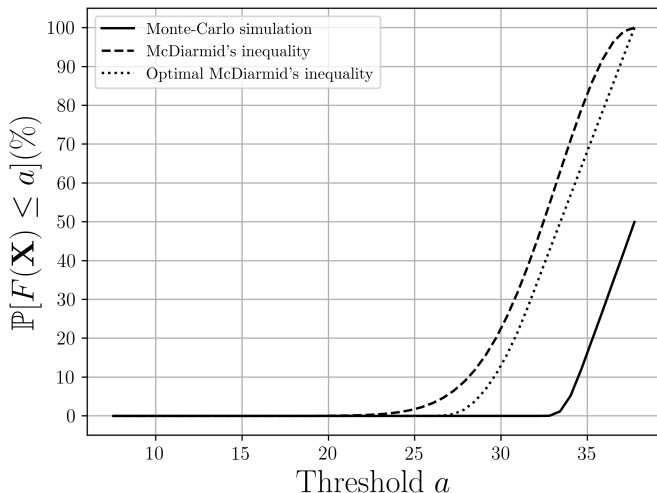
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- **Scenario 2:** Let  $\mathcal{A}_F$  be the following admissible set

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where:

$$\begin{array}{lll} M : & \mathcal{X}_1 = [\underline{M} \pm 0.05] & \underline{M} = 0.6 \quad D_1 = 2.435, \\ \alpha : & \mathcal{X}_2 = [\underline{\alpha} \pm 0.25^\circ] & \underline{\alpha} = 0.75^\circ \quad D_2 = 8.579, \\ t : & \mathcal{X}_3 = [\underline{t} \pm 5\%] & \underline{t} = 0\% \quad D_3 = 0.708. \end{array}$$

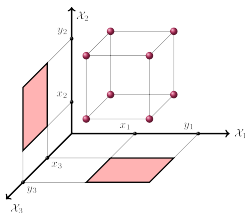
## Example #2 – Scenario 1



## Example #2 – Scenario 2

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The marginal measures  $\mu_1$ ,  $\mu_2$  and  $\mu_3$  are supported on [at most](#) 2 Dirac points. The support of  $\mu$  consists in at most 8 Dirac support points.

- $\mathcal{U}[\mathcal{A}_\Delta]$  is found using Storn-Price's Differential Evolution algorithm in the [mystic](#) framework.

R. Storn, K. Price. *J. Global Optim.* **11**(4), 341-359 (1997)

## Example #2 – Summary

Threshold		$a = 35$
Admissible scenario		$\sup_{(f,\mu) \in \mathcal{A}} \mathbb{P}_{\mathbf{X} \sim \mu}[f(\mathbf{X}) \leq a]$
Scenario 1	McDiarmid's inequality	$\leq 83.0\%$
	$\mathcal{U}[\mathcal{A}_{\text{MCD}}]$	$= 68.2\%$
Scenario 2	$\mathcal{U}[\mathcal{A}_F]$	$= 65.5\%$
Scenario 0	$\mathbb{P}[F(\mathbf{X}) \leq a]$ (MC over $10^5$ samples)	$= 16.3\%$

Upper bounds of the probability of failure with threshold  $a = 0.35$  for different scenarios.

- $\mathcal{U}[\mathcal{A}_\Delta]$  is computed using *e.g.* Storn-Price's differential evolution algorithm, which can be massively parallelized;
- Even after reduction of the optimization problem this approach remains complex: no optimal solution might ever be found;
- One can use the properties of  $a \mapsto \mathcal{U}[\mathcal{A}](a)$  ( *e.g.* monotonous) to ensure the validity of the numerical optimal results.

*We study the adaptive reconstruction of  $a \mapsto \mathcal{U}[\mathcal{A}](a) = \sup_{(f, \mu) \in \mathcal{A}} \mu[f(\mathbf{X}) \leq a]$  when  $a \in [a_0, a_1]$*

# Outline

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1 Certification and UQ

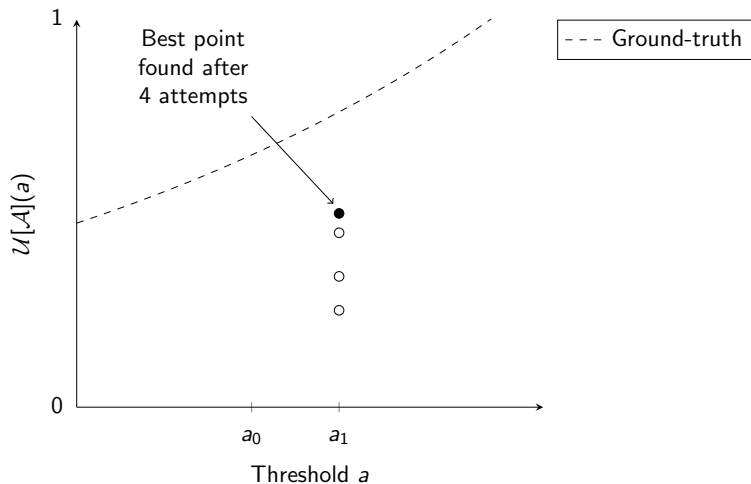
2 Optimal Uncertainty Quantification

3 Examples

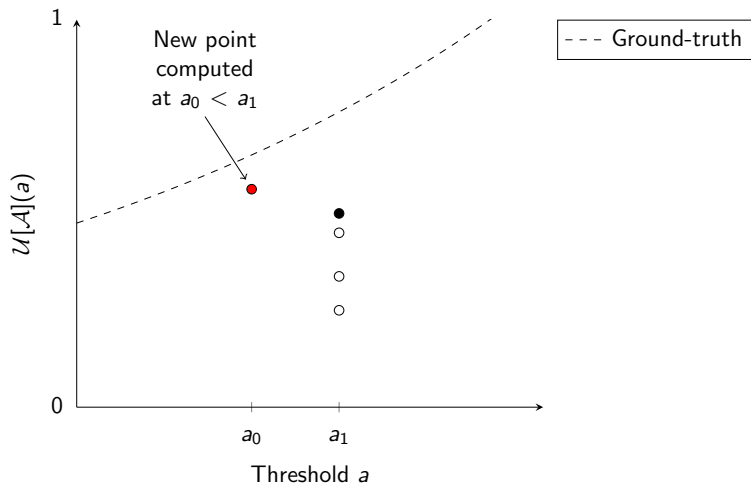
4 Adaptive reconstruction



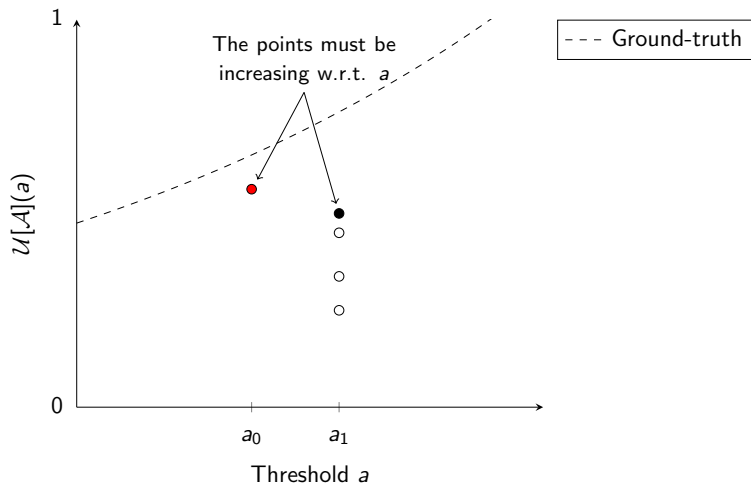
# Consistency



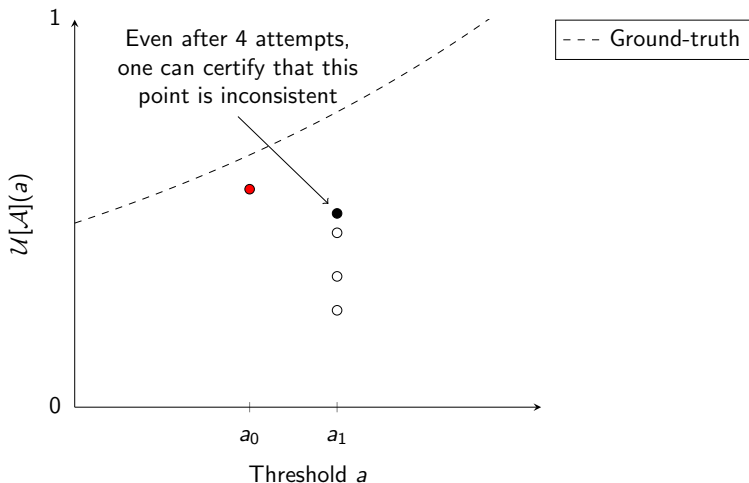
# Consistency



# Consistency



# Consistency



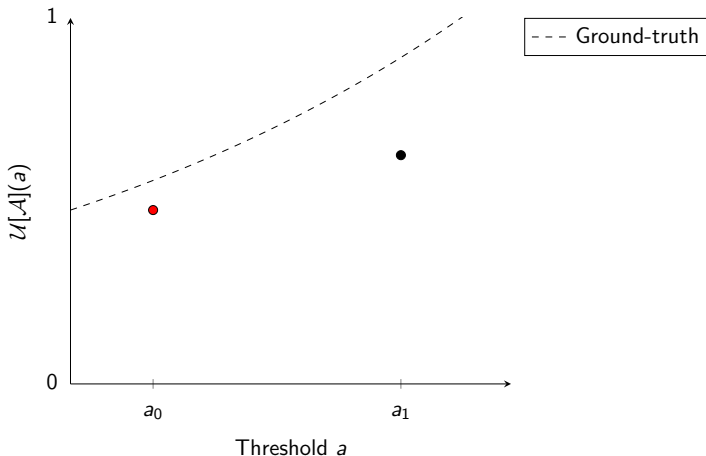
# Adaptive reconstruction

- This reasoning can be applied for different properties of the ground-truth function  $\mathcal{U}[\mathcal{A}](a)$ : increasing, decreasing, convex, *etc*;
- Going further: Reconstruction of the whole ground-truth function over a closed interval  $[a_0, a_1]$ ;
- This can be automated once a metamodel/algorithm  $\mathcal{G}(a; q)$  with numerical parameters  $q$  is available: L. Bonnet, J.-L. Akian, É. Savin, T. J. Sullivan, *Algorithms* **13**(8),196 (2020).



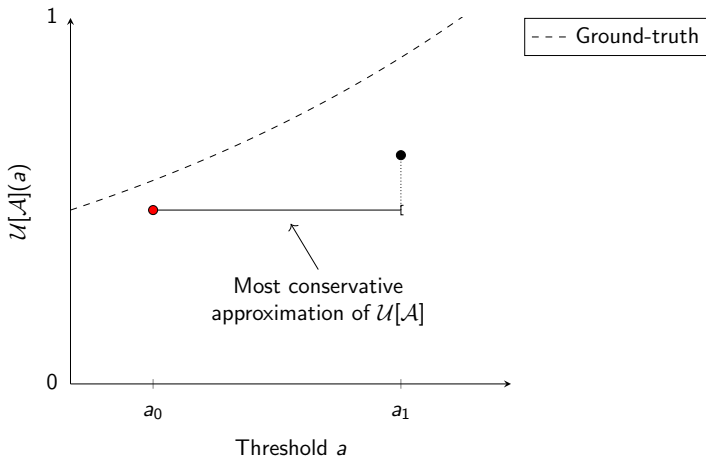
# Reconstruction as a piecewise constant function

Reconstruction of the ground-truth function  $\mathcal{U}[\mathcal{A}](a)$  on  $[a_0, a_1]$  with algorithm  $\mathcal{G}(a; q)$



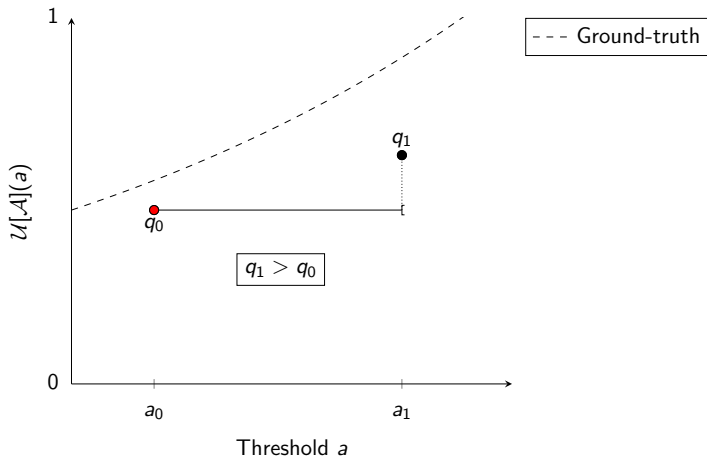
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# Reconstruction as a piecewise constant function

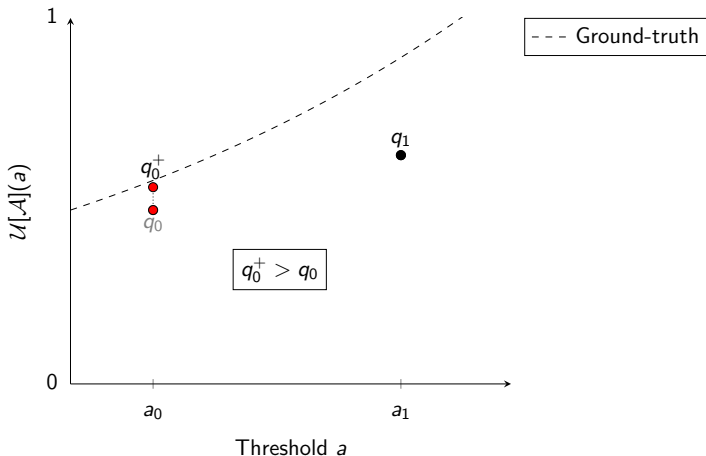
Reconstruction of the ground-truth function  $\mathcal{U}[\mathcal{A}](a)$  on  $[a_0, a_1]$  with algorithm  $\mathcal{G}(a; q)$





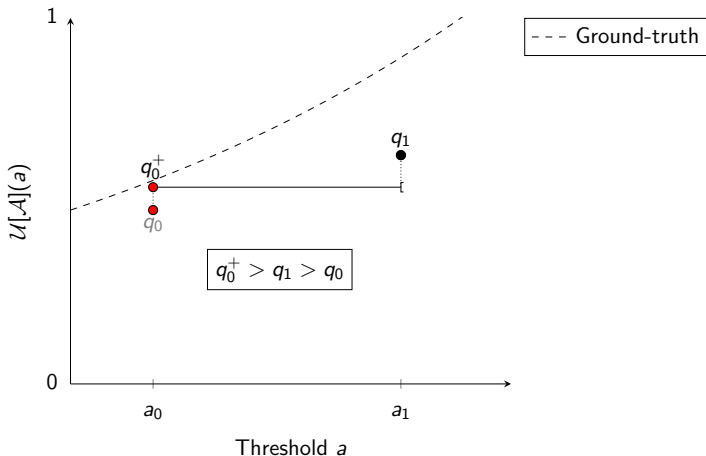
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Reconstruction of the ground-truth function  $\mathcal{U}[\mathcal{A}](a)$  on  $[a_0, a_1]$  with algorithm  $\mathcal{G}(a; q)$



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Reconstruction of the ground-truth function  $\mathcal{U}[\mathcal{A}](a)$  on  $[a_0, a_1]$  with algorithm  $\mathcal{G}(a; q)$



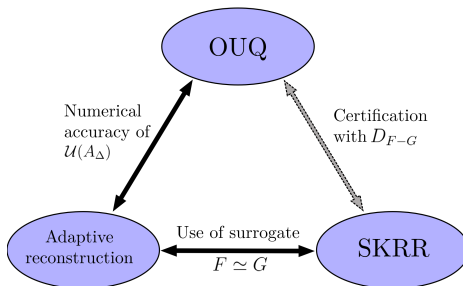
# Adaptive reconstruction

- The choice of redoing a poor-quality evaluation of  $\mathcal{U}[\mathcal{A}]$  over adding a new point is controlled by a user-defined parameter  $\mathcal{E} > 0$ :
  - $\mathcal{E} \gg 1$ : Split over redo the worst quality point;
  - $\mathcal{E} \ll 1$ : Redo the worst quality point over split.
- The convergence of the algorithm is proved and depend on the smoothness of  $\mathcal{U}[\mathcal{A}]$ .

# Outlook

- Several tens of thousands of function evaluations  $\mathbf{X} \mapsto F(\mathbf{X})$  are typically required to obtain one data point using *e.g.* *mystic* and Storn-Price's algorithm;
- The algorithm is computationally intensive in order to get a new data point;
- Use of a surrogate model  $\mathbf{X} \mapsto G(\mathbf{X})$  is highly desirable. The value obtained through the optimization process will strongly depend on the quality of this surrogate model.

$$\mathcal{U}[\mathcal{A}](a) = \sup_{\mu \in \mathcal{A}} \mu[F(\mathbf{X}) \leq a] \simeq \sup_{\mu \in \mathcal{A}} \mu[G(\mathbf{X}) \leq a]$$



J.-L. Akian, L. Bonnet, H. Owhadi, É. Savin, *J. Comput. Phys.* **470**, 111595 (2022)